TEXAS INSTRUMENTS

INA250A1, INA250A2, INA250A3, INA250A4
JAJSR87C – APRIL 2015 – REVISED SEPTEMBER 2023

INA250 シャント抵抗内蔵、36V、双方向、高精度電流センス・アンプ

1 特長

- 高精度のシャント抵抗を内蔵
  - シャント抵抗:2mΩ
  - シャント抵抗の許容誤差:0.1% (最大値)
  - -40℃～85℃で 15A の連続電流
  - 0℃～125℃の温度係数:
    10ppm/℃
- 高精度:
  - ゲイン誤差 (シャントとアンプ):0.3% (最大値)
  - オフセット電流:50mA (最大値、INA250A2)
- 4 種類のゲインを利用可能
  - INA250A1:200mV/A
  - INA250A2:500mV/A
  - INA250A3:800mV/A
  - INA250A4:2V/A
- 広い同相モード範囲:-0.1V～36V
- 規定動作温度:-40℃～125℃

2 アプリケーション

- 試験装置
- 電源
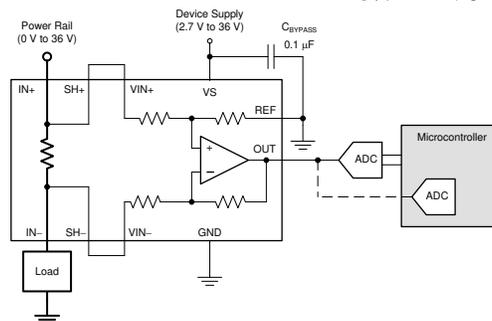- サーバー
- 通信機器
- 車載
- 太陽光インバータ
- パワー・マネージメント

3 概要

INA250 は、電源電圧にかかわらず 0V～36V の同相電圧で高精度電流測定を可能にするためのシャント抵抗を内蔵した電圧出力、電流センシング・アンプのファミリです。本デバイスは、内蔵電流センシング抵抗センサを両方向に流れる電流を外部基準電圧を使って測定できる双方向のローサイドまたはハイサイド電流シャント・モニタです。高精度の電流センシング抵抗が内蔵されているため、較正と等価の測定精度があり、温度ドリフト係数が非常に低く、センシング抵抗について最適化されたケルビン・レイアウトが常に得られることが保証されます。

INA250 ファミリは、4 種類の出力電圧スケールで供給されます。200mV/A、500mV/A、800mV/A、および 2V/A です。このデバイスは、最大温度 125℃で最大 10A の連続電流について完全にテストして規定されています。INA250 は単一の 2.7V～36V の電源で動作し、消費電流は最大 300μA です。INA250 のすべてのゲイン・バージョンは、拡張動作温度範囲 (-40℃～125℃) で動作が規定され、TSSOP-16 パッケージで供給されます。

パッケージ情報

部品番号	パッケージ [1]	パッケージ・サイズ [2]
INA250A1	PW (TSSOP、16)	5.00mm × 6.40mm
INA250A2		
INA250A3		
INA250A4		

(1) 利用可能なすべてのパッケージについては、データシートの末尾にある注文情報を参照してください。

(2) パッケージ・サイズ (長さ×幅) は公称値であり、該当する場合はピンも含まれます。

概略回路図

Table of Contents

4 Revision History

Changes from Revision B (December 2015) to Revision C (September 2023)   **Page**

- ドキュメント全体にわたって表、図、相互参照の採番方法を変更.. 1
- 「製品情報」表を「パッケージ情報」に変更 1
- Changed the *Shunt resistance (SH+ to SH–)* minimum value for use as stand-alone resistor from: 1.9 mΩ to 1.8 mΩ in the *Electrical Characteristics* table... 5
- Changed the *Shunt resistance (SH+ to SH–)* minimum value for use as stand-alone resistor from: 2.1 mΩ to 2.2 mΩ in the *Electrical Characteristics* table... 5

Changes from Revision A (May 2015) to Revision B (December 2015)   **Page**

- INA250A1、INA250A3、および INA250A4 を量産用にリリース... 1
- TI Design を追加.. 1
- Added parameters for INA250A1, INA250A3, and INA250A4 to *Electrical Characteristics* table.................. 5
- Added ± to specifications for the *Shunt short time overload*, *Shunt thermal shock*, *Shunt resistance to solder heat*, *Shunt high temperature exposure*, and *Shunt cold temperature storage* parameters of *Electrical Characteristics* table.. 5
- Added curves for INA250A1, INA250A3, and INA250A4 to *Typical Characteristics* section 7
- Added *Amplifier Operation* section 15

Changes from Revision * (April 2015) to Revision A (May 2015)   **Page**

- INA250A2 を量産用にリリース... 1

Product Folder Links: *INA250A1 INA250A2 INA250A3 INA250A4*

English Data Sheet: SBOS511

5 Pin Configuration and Functions

```
        IN-  ┌  1        ○       16  ┐  IN+
        IN-  ┌  2                15  ┐  IN+
        IN-  ┌  3                14  ┐  IN+
        SH-  ┌  4                13  ┐  SH+
        VIN- ┌  5                12  ┐  VIN+
        GND  ┌  6                11  ┐  GND
        REF  ┌  7                10  ┐  VS
        GND  ┌  8                 9  ┐  OUT
```
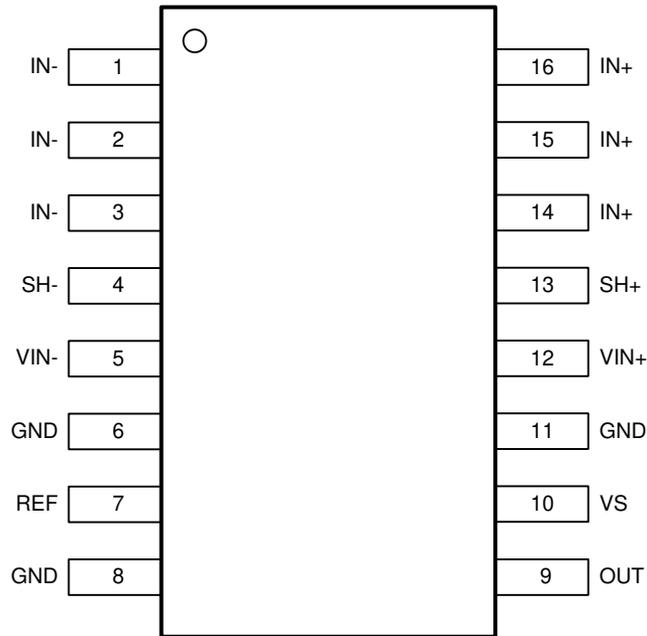
図 5-1. PW Package 16-Pin TSSOP Top View

表 5-1. Pin Functions

PIN		I/O	DESCRIPTION
NAME	NO.		
GND	6, 8, 11	Analog	Ground
IN–	1, 2, 3	Analog input	Connect to load
IN+	14, 15, 16	Analog input	Connect to supply
OUT	9	Analog output	Output voltage
REF	7	Analog input	Reference voltage, 0 V to VS (up to 18 V)
SH–	4	Analog output	Kelvin connection to internal shunt. Connect to VIN– if no filtering is needed. See 図 7-4 for filter recommendations.
SH+	13	Analog output	Kelvin connection to internal shunt. Connect to VIN+ if no filtering is needed. See 図 7-4 for filter recommendations.
VIN–	5	Analog input	Voltage input from load side of shunt resistor.
VIN+	12	Analog input	Voltage input from supply side of shunt resistor.
VS	10	Analog	Device power supply, 2.7 V to 36 V

Product Folder Links: *INA250A1 INA250A2 INA250A3 INA250A4*

English Data Sheet: SBOS511

6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)[1]

		MIN	MAX	UNIT
Supply voltage (VS)			40	V
Analog input current	Continuous current		±15	A
Analog inputs (IN+, IN–)	Common-mode	GND – 0.3	40	V
Analog inputs (VIN+, VIN–)	Common-mode	GND – 0.3	40	V
	Differential $(V_{IN+}) - (V_{IN-})$	–40	40	
Analog inputs (REF)		GND – 0.3	VS + 0.3	V
Analog outputs (SH+, SH–)	Common-mode	GND – 0.3	40	V
Analog outputs (OUT)		GND – 0.3	(VS + 0.3) up to 18	V
Temperature	Operating, T_A	–55	150	°C
	Junction, T_J		150	
	Storage, T_{stg}	–65	150	

(1) Stresses above these ratings may cause permanent damage. Exposure to absolute maximum conditions for extended periods may degrade device reliability. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those specified is not implied.

6.2 ESD Ratings

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001[1]	±2000	V
		Charged-device model (CDM), per JEDEC specification JESD22-C101[2]	±1000	

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

		MIN	NOM	MAX	UNIT
V_{CM}	Common-mode input voltage	0		36	V
VS	Operating supply voltage	2.7		36	V
T_A	Operating free-air temperature	–40		125	°C

6.4 Thermal Information

		INA250	UNIT
	THERMAL METRIC[1]	PW (TSSOP)	
		16 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	104.4	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	42.3	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	48.5	°C/W
ψ_{JT}	Junction-to-top characterization parameter	4.5	°C/W
ψ_{JB}	Junction-to-board characterization parameter	48	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	N/A	°C/W

(1) For more information about traditional and new thermal metrics, see the *IC Package Thermal Metrics* application report, SPRA953.

Product Folder Links: *INA250A1 INA250A2 INA250A3 INA250A4*

English Data Sheet: SBOS511

6.5 Electrical Characteristics

At T_A = 25°C, VS = 5 V, V_{IN+} = 12 V, V_{REF} = 2.5 V, I_{SENSE} = IN+ = 0 A, unless otherwise noted.

PARAMETER		CONDITIONS	MIN	TYP	MAX	UNIT
INPUT						
V_{CM}	Common-mode input range		−0.1		36	V
CMR	Common-mode rejection	INA250A1, V_{IN+} = 0 V to 36 V, T_A = −40°C to 125°C	94	102		dB
		INA250A2, V_{IN+} = 0 V to 36 V, T_A = −40°C to 125°C	97	110		
		INA250A3, V_{IN+} = 0 V to 36 V, T_A = −40°C to 125°C	106	114		
		INA250A4, V_{IN+} = 0 V to 36 V, T_A = −40°C to 125°C	108	118		
I_{OS}	Offset current, RTI[1]	INA250A1, I_{SENSE} = 0 A		±15	±100	mA
		INA250A2, I_{SENSE} = 0 A		±12.5	±50	
		INA250A3, I_{SENSE} = 0 A		±5	±30	
		INA250A4, I_{SENSE} = 0 A		±5	±20	
dI_{OS}/dT	RTI versus temperature	T_A = −40°C to 125°C		25	250	µA/°C
PSR		VS = 2.7 V to 36 V, T_A = −40°C to 125°C		±0.03	±1	mA/V
I_B	Input bias current	I_{B+}, I_{B-}, I_{SENSE} = 0 A		±28	±35	µA
V_{REF}	Reference input range[3]		0		(VS) up to 18	V
SHUNT RESISTOR[5]						
R_{SHUNT}	Shunt resistance (SH+ to SH−)	Equivalent resistance when used with onboard amplifier	1.998	2	2.002	mΩ
		Used as stand-alone resistor[7]	1.8	2	2.2	
	Package resistance	IN+ to IN−		4.5		mΩ
	Resistor temperature coefficient	T_A = −40°C to 125°C		15		ppm/°C
		T_A = −40°C to 0°C		50		
		T_A = 0°C to 125°C		10		
I_{SENSE}	Maximum continuous current[4]	T_A = −40°C to 85°C			±15	A
	Shunt short time overload	I_{SENSE} = 30 A for 5 seconds		±0.05%		
	Shunt thermal shock	−65°C to 150°C, 500 cycles		±0.1%		
	Shunt resistance to solder heat	260°C solder, 10 s		±0.1%		
	Shunt high temperature exposure	1000 hours, T_A = 150°C		±0.15%		
	Shunt cold temperature storage	24 hours, T_A = −65°C		±0.025%		

Product Folder Links: *INA250A1 INA250A2 INA250A3 INA250A4*

English Data Sheet: SBOS511

At T_A = 25°C, VS = 5 V, V_{IN+} = 12 V, V_{REF} = 2.5 V, I_{SENSE} = IN+ = 0 A, unless otherwise noted.

PARAMETER		CONDITIONS	MIN	TYP	MAX	UNIT
OUTPUT						
G	Gain	INA250A1		200		mV/A
		INA250A2		500		
		INA250A3		800		
		INA250A4		2		V/A
	System gain error[6]	I_{SENSE} = –10 A to 10 A, T_A = 25°C		±0.05%	±0.3%	
		I_{SENSE} = –10 A to 10 A, T_A = –40°C to 125°C			±0.75%	
		T_A = –40°C to 125°C			45	ppm/°C
	Nonlinearity error	I_{SENSE} = 0.5 A to 10 A		±0.03%		
R_O	Output impedance			1.5		Ω
	Maximum capacitive load	No sustained oscillation		1		nF
VOLTAGE OUTPUT[2]						
	Swing to VS power-supply rail	R_L = 10 kΩ to GND		(VS) – 0.1	(VS) – 0.2	V
	Swing to GND	R_L = 10 kΩ to GND		(V_{GND}) + 25	(V_{GND}) + 50	mV
FREQUENCY RESPONSE						
BW	Bandwidth	INA250A1, C_L = 10 pF		50		kHz
		INA250A2, C_L = 10 pF		50		
		INA250A3, C_L = 10 pF		35		
		INA250A4, C_L = 10 pF		11		
SR	Slew rate	C_L = 10 pF		0.2		V/μs
NOISE, RTI[1]						
	Voltage noise density	INA250A1		51		nV/√$\overline{Hz}$
		INA250A2		35		
		INA250A3		37		
		INA250A4		27		
POWER SUPPLY						
VS	Operating voltage range		2.7		36	V
I_Q	Quiescent current	T_A = –40°C to 125°C		200	300	μA
TEMPERATURE RANGE						
	Specified range		–40		125	°C

(1) RTI = referred-to-input.

(2) See *Typical Characteristics* curve, *Output Voltage Swing vs Output Current* (図 6-19).

(3) The supply voltage range maximum is 36 V, but the reference voltage cannot be higher than 18 V.

(4) See 図 7-1 and the *Layout* section for additional information on the current derating and layout recommendations to improve the current handling capability of the device at higher temperatures.

(5) See the セクション 7.3.1 section for additional information regarding the integrated current-sensing resistor.

(6) System gain error includes amplifier gain error and the integrated sense resistor tolerance. System gain error does not include the stress related characteristics of the integrated sense resistor. These characteristics are described in the *Shunt Resistor* section of the *Electrical Characteristics* table.

(7) The internal shunt resistor is intended to be used with the internal amplifier and is not intended to be used as a stand-alone resistor. See the *Integrated Shunt Resistor* section for more information.

Product Folder Links: *INA250A1 INA250A2 INA250A3 INA250A4*

English Data Sheet: *SBOS511*

6.6 Typical Characteristics

At T_A = 25°C, VS = 5 V, V_{IN+} = 12 V, V_{REF} = 2.5 V, I_{SENSE} = IN+ = 0 A, unless otherwise noted.
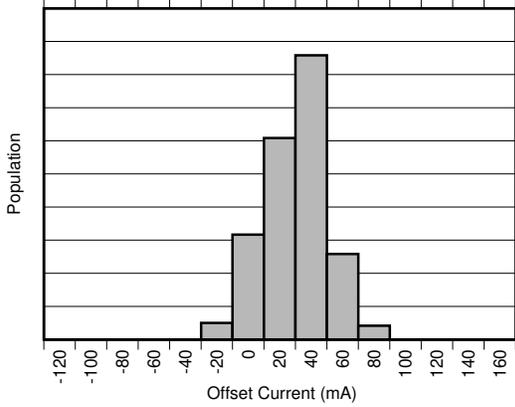

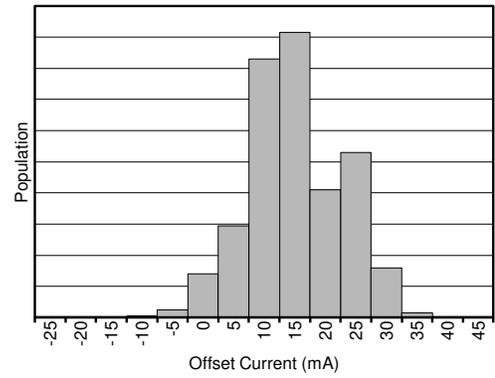**図 6-1. INA250A1 Input Offset Distribution**

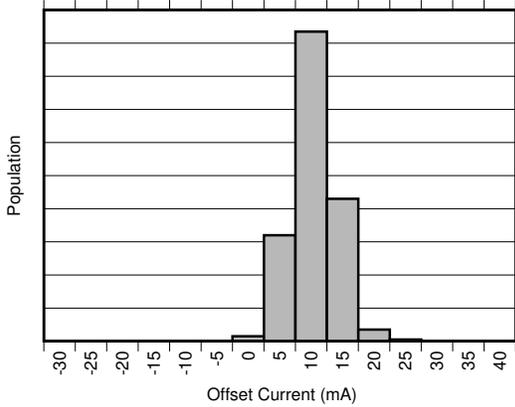**図 6-2. INA250A2 Input Offset Distribution**

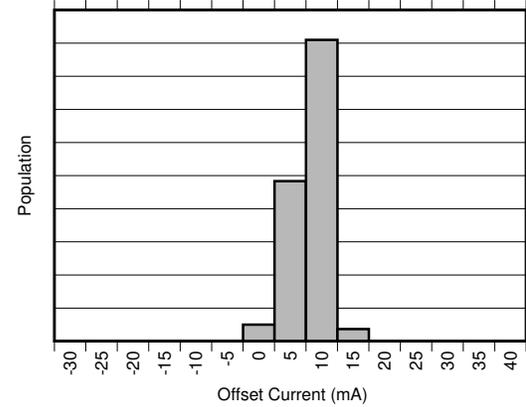**図 6-3. INA250A3 Input Offset Distribution**
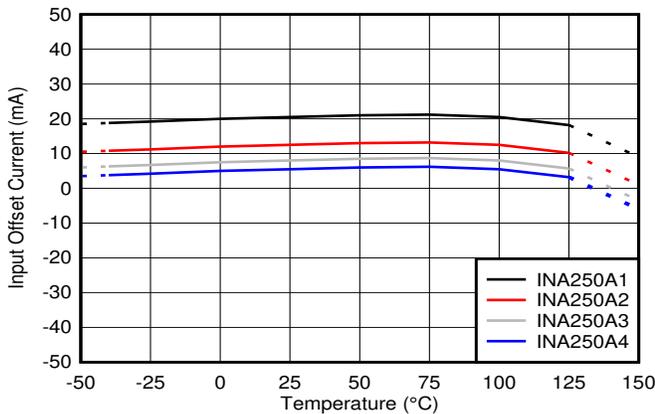

図 6-4. INA250A4 Input Offset Distribution

図 6-5. Input Offset vs Temperature
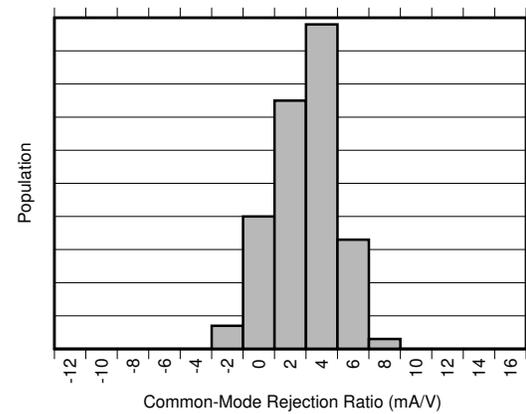
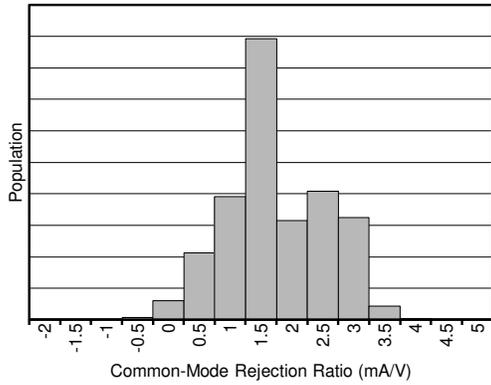**図 6-6. INA250A1 Common-Mode Rejection Ratio Distribution**
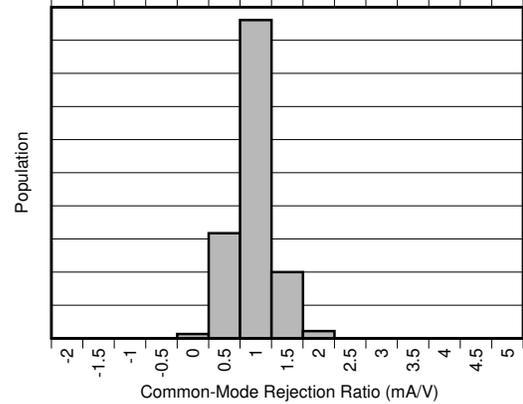
図 6-7. INA250A2 Common-Mode Rejection Ratio Distribution

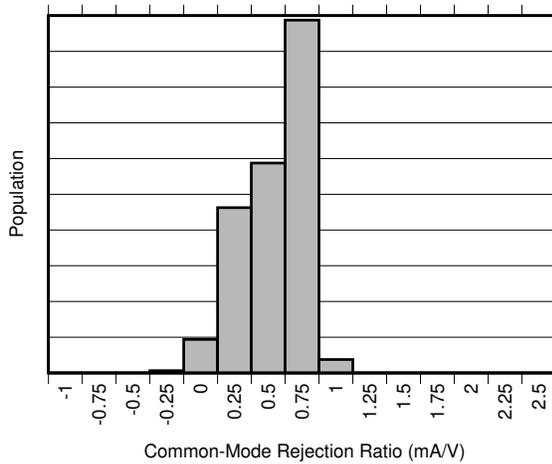図 6-8. INA250A3 Common-Mode Rejection Ratio Distribution

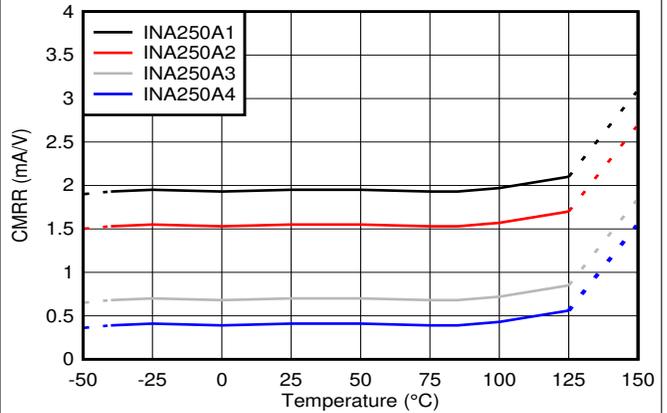図 6-9. INA250A4 Common-Mode Rejection Ratio Distribution
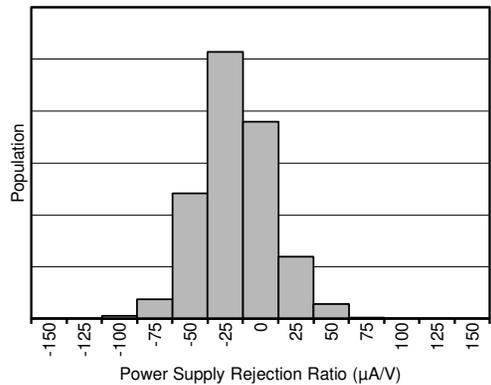

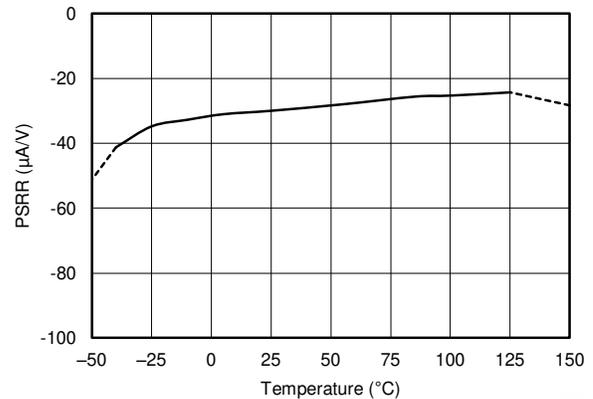図 6-10. Common-Mode Rejection Ratio vs Temperature

図 6-11. Power-Supply Rejection Ratio Distribution

図 6-12. Power-Supply Rejection Ratio vs Temperature

Product Folder Links: *INA250A1 INA250A2 INA250A3 INA250A4*

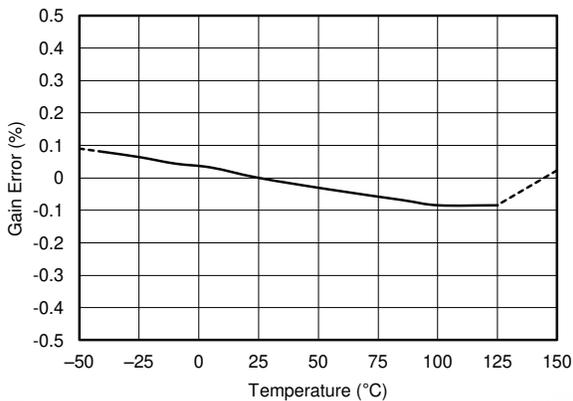English Data Sheet: SBOS511
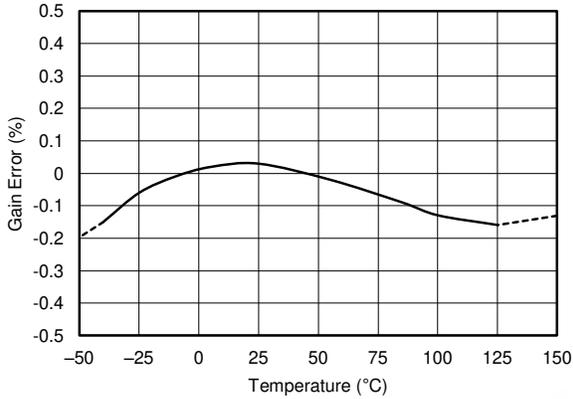
図 6-13. System Gain Error vs Temperature
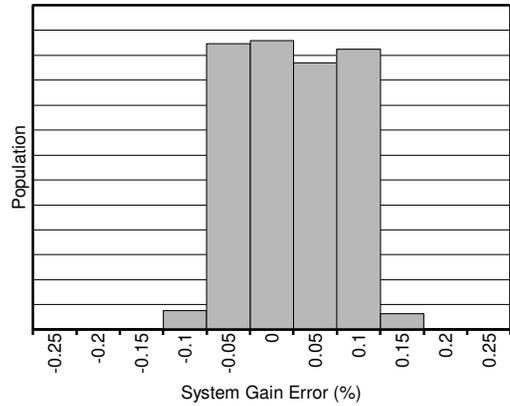
System gain error = R_{SHUNT} error + amplifier gain error, load current = 10 A

図 6-14. System Gain Error Distribution

図 6-15. Amplifier Gain Error vs Temperature
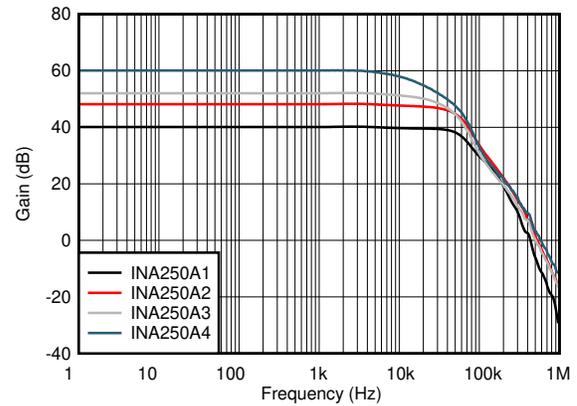
V_{CM} = 12 V, I_{SENSE} = 500 mA$_{PP}$

図 6-16. Amplifier Gain vs Frequency
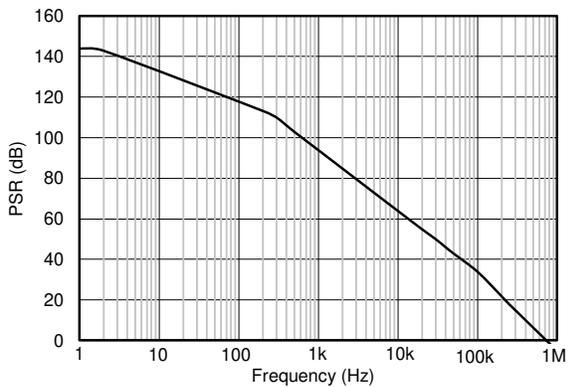
V_{CM} = 12 V, V_{REF} = 2.5 V, I_{SENSE} = 0 A, VS = 5 V + 250-mV sine disturbance

図 6-17. Power-Supply Rejection vs Frequency
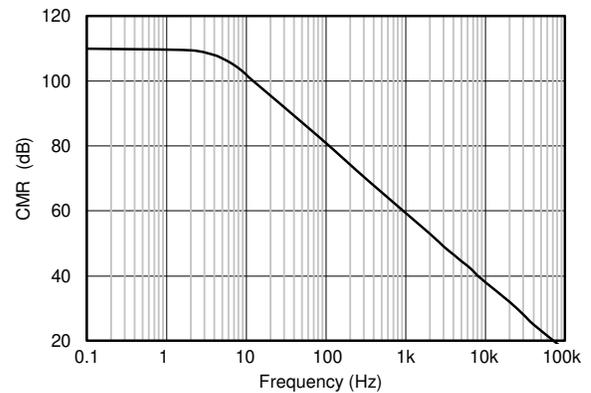
VS = 5 V, V_{REF} = 2.5 V, I_{SENSE} = 0 A, V_{CM} = 1-V sine wave

図 6-18. Common-Mode Rejection vs Frequency

Product Folder Links: *INA250A1 INA250A2 INA250A3 INA250A4*

English Data Sheet: SBOS511
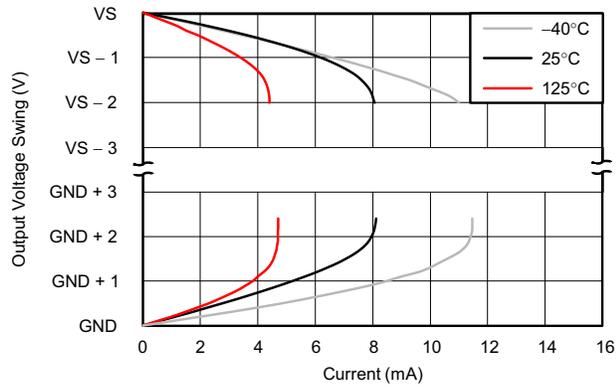
図 6-19. Output Voltage Swing vs Output Current
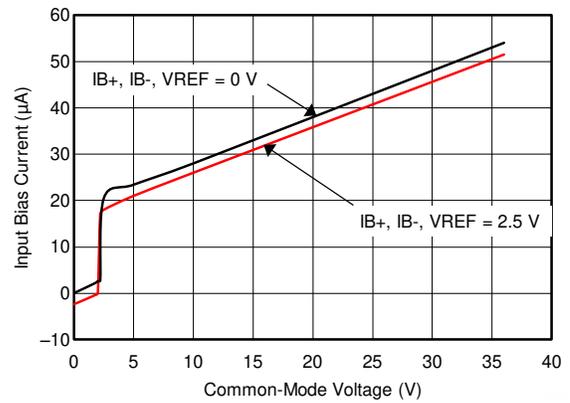
I_{SENSE} = 0 A, VS = 5 V

図 6-20. Input Bias Current vs Common-Mode Voltage (VS = 5 V)

I_{SENSE} = 0 A, VS = 0 V, VREF = 0 V
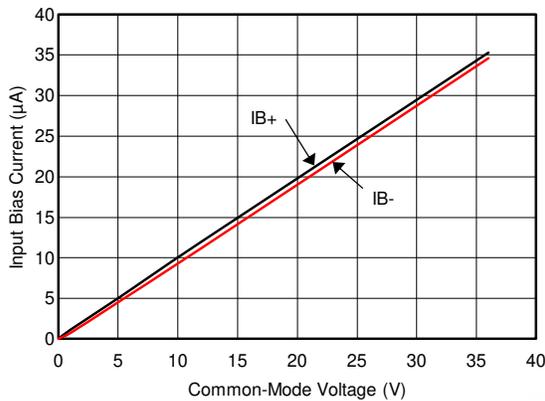
図 6-21. Input Bias Current vs Common-Mode Voltage (VS = 0 V)

I_{SENSE} = 0 A, VS = 5 V
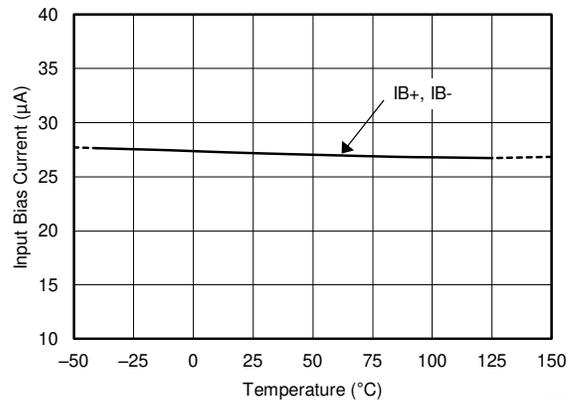
図 6-22. Input Bias Current vs Temperature
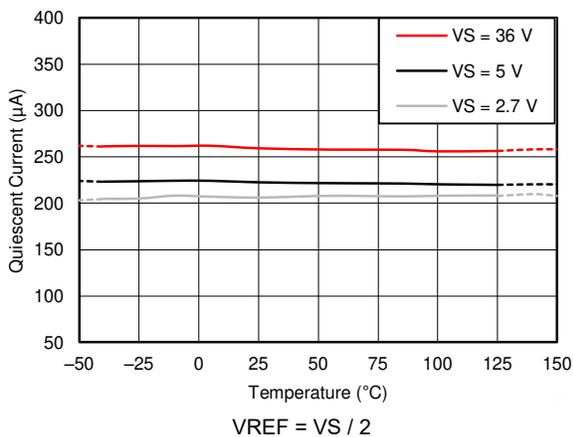
VREF = VS / 2

図 6-23. Quiescent Current vs Temperature
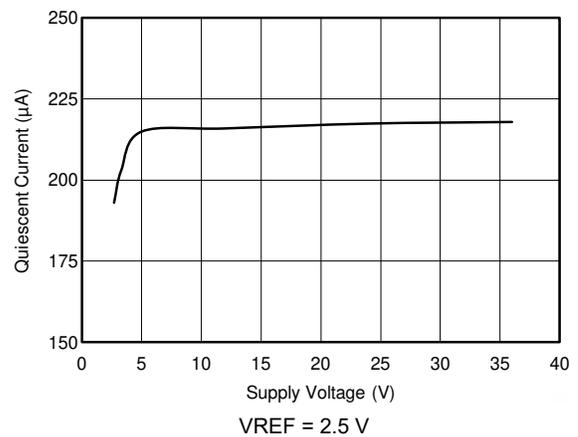
VREF = 2.5 V

図 6-24. Quiescent Current vs Supply Voltage

English Data Sheet: SBOS511
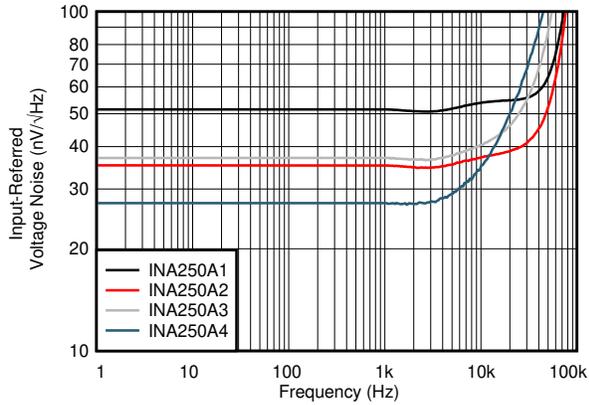
VS = 5 V, V_{REF} = 2.5 V, I_{SENSE} = 0 A

図 6-25. Input-Referred Voltage Noise vs Frequency
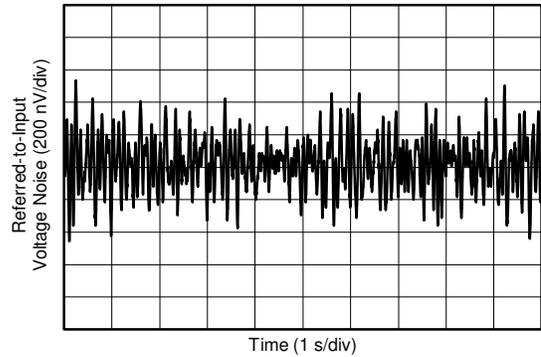
VS = 5 V, V_{CM} = 0 V, I_{SENSE} = 0 A

図 6-26. 0.1-Hz to 10-Hz Voltage Noise (Referred-to-Input)
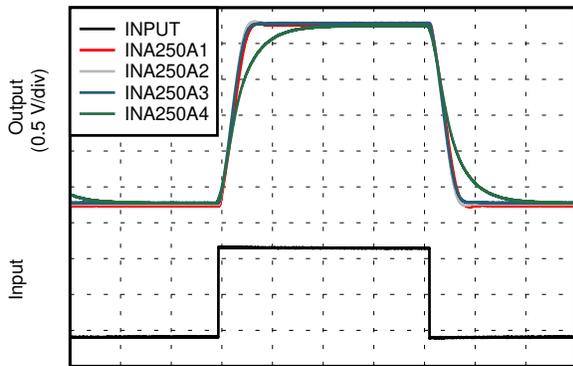
Input = (VIN+) - (VIN-)

図 6-27. Step Response

Input = VIN+, V_{REF} = 2.5 V

図 6-28. Common-Mode Transient Response

図 6-29. Start-Up Response

Product Folder Links: *INA250A1 INA250A2 INA250A3 INA250A4*

English Data Sheet: SBOS511

7 Detailed Description

7.1 Overview

The INA250 features a 2-mΩ, precision, current-sensing resistor and a 36-V common-mode, zero-drift topology, precision, current-sensing amplifier integrated into a single package. High precision measurements are enabled through the matching of the shunt resistor value and the current-sensing amplifier gain providing a highly-accurate, system-calibrated solution. Multiple gain versions are available to allow for the optimization of the desired full-scale output voltage based on the target current range expected in the application.

7.2 Functional Block Diagram
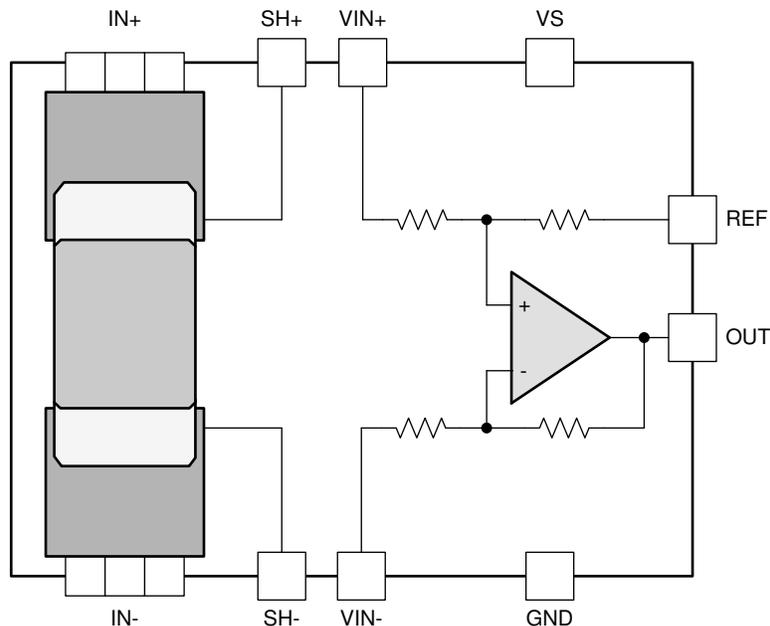
7.3 Feature Description

7.3.1 Integrated Shunt Resistor

The INA250 features a precise, low-drift, current-sensing resistor to allow for precision measurements over the entire specified temperature range of −40°C to 125°C. The integrated current-sensing resistor ensures measurement stability over temperature as well as improving layout and board constraint difficulties common in high precision measurements.

The onboard current-sensing resistor is designed as a 4-wire (or Kelvin) connected resistor that enables accurate measurements through a force-sense connection. Connecting the amplifier inputs pins (VIN− and VIN+) to the sense pins of the shunt resistor (SH− and SH+) eliminates many of the parasitic impedances commonly found in typical very-low sensing-resistor level measurements. Although the sense connection of the current-sensing resistor can be accessed via the SH+ and SH− pins, this resistor is not intended to be used as a stand-alone component. The INA250 is system-calibrated to ensure that the current-sensing resistor and current-sensing amplifier are both precisely matched to one another. Use of the shunt resistor without the onboard amplifier results in a current-sensing resistor tolerance of approximately 5%. To achieve the optimized system gain specification, the onboard sensing resistor must be used with the internal current-sensing amplifier.

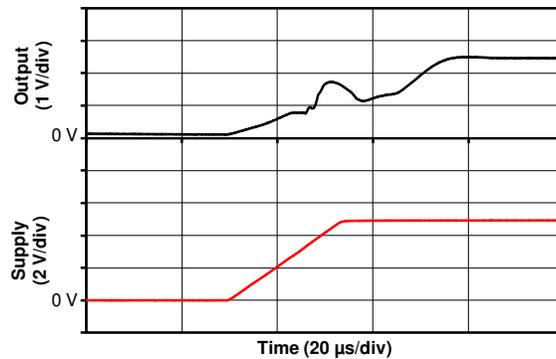The INA250 has approximately 4.5 mΩ of package resistance. 2 mΩ of this total package resistance is a precisely-controlled resistance from the Kelvin-connected current-sensing resistor used by the amplifier. The power dissipation requirements of the system and package are based on the total 4.5-mΩ package resistance between the IN+ and IN− pins. The heat dissipated across the package when current flows through the device ultimately determines the maximum current that can be safely handled by the package. The current consumption of the silicon is relatively low, leaving the total package resistance carrying the high load current as the primary contributor to the total power dissipation of the package. The maximum safe-operating current level is set to

ensure that the heat dissipated across the package is limited so that no damage to the resistor or the package itself occurs or that the internal junction temperature of the silicon does not exceed a 150°C limit.

External factors (such as ambient temperature, external air flow, and PCB layout) can contribute to how effectively the heat developed as a result of the current flowing through the total package resistance can be removed from within the device. Under the conditions of no air flow, a maximum ambient temperature of 85°C, and 1-oz. copper input power planes, the INA250 can accommodate continuous current levels up to 15 A. As shown in 図 7-1, the current handling capability is derated at temperatures above the 85°C level with safe operation up to 10 A at a 125°C ambient temperature. With air flow and larger 2-oz. copper input power planes, the INA250 can safely accommodate continuous current levels up to 15 A over the entire −40°C to 125°C temperature range.
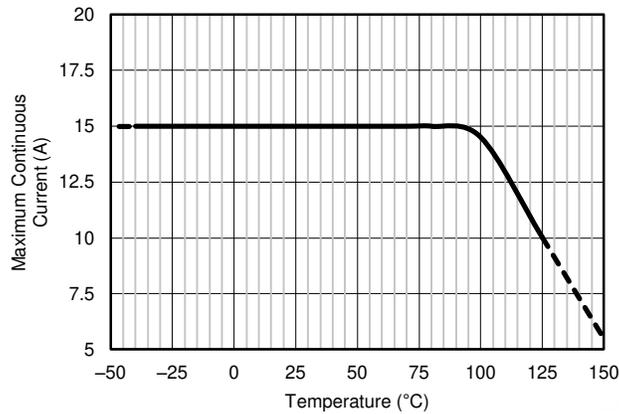
図 7-1. Maximum Current vs Temperature

7.3.2 Short-Circuit Duration

The INA250 features a physical shunt resistance that is able to withstand current levels higher than the continuous handling limit of 15 A without sustaining damage to the current-sensing resistor or the current-sensing amplifier if the excursions are very brief. 図 7-2 shows the short-circuit duration curve for the INA250.
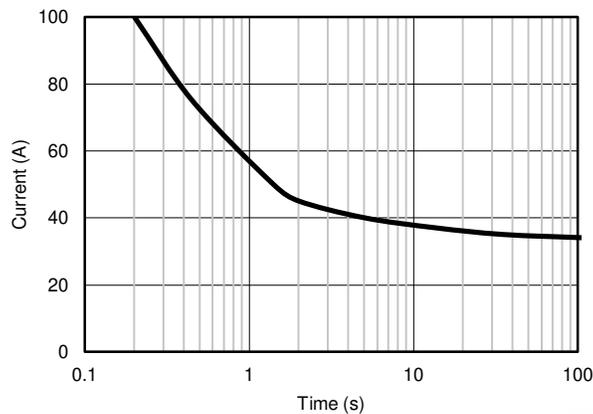
図 7-2. Short-Circuit Duration

7.3.3 Temperature Stability

System calibration is common for many industrial applications to eliminate initial component and system-level errors that can be present. A system-level calibration can reduce the initial accuracy requirement for many of the individual components because the errors associated with these components are effectively eliminated through the calibration procedure. Performing this calibration can enable precision measurements at the temperature in which the system is calibrated, but as the system temperature changes as a result of external

ambient changes or due to self heating, measurement errors are reintroduced. Without accurate temperature compensation used in addition to the initial adjustment, the calibration procedure is not effective in accounting for these temperature-induced changes. One of the primary benefits of the very low temperature coefficient of the INA250 (including both the integrated current-sensing resistor and current-sensing amplifier) is ensuring that the device measurement remains highly accurate, even when the temperature changes throughout the specified temperature range of the device.

For the integrated current-sensing resistor, the drift performance is shown in 図 7-3. Although several temperature ranges are specified in the *Electrical Characteristics* table, applications operating in ranges other than those described can use 図 7-3 to determine how much variance in the shunt resistor value can be expected. As with any resistive element, the tolerance of the component varies when exposed to different temperature conditions. For the current-sensing resistor integrated in the INA250, the resistor does vary slightly more when operated in temperatures ranging from –40°C to 0°C than when operated from 0°C to 125°C. However, even in the –40°C to 0°C temperature range, the drift is still quite low at 25 ppm/°C.
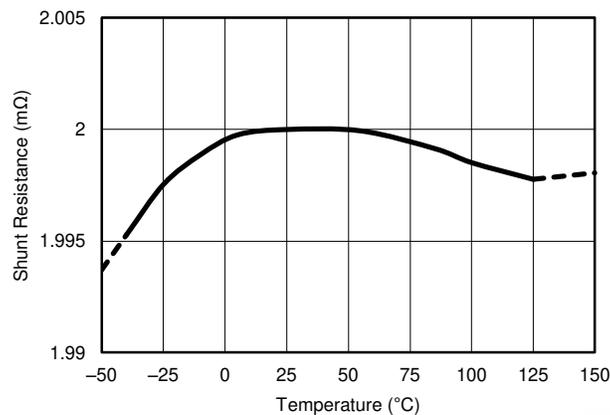
図 7-3. Sensing Resistor vs Temperature

An additional aspect to consider is that when current flows through the current-sensing resistor, power is dissipated across this component. This dissipated power results in an increase in the internal temperature of the package, including the integrated sensing resistor. This resistor self-heating effect results in an increase of the resistor temperature helping to move the component out of the colder, wider drift temperature region.

Product Folder Links: *INA250A1 INA250A2 INA250A3 INA250A4*

English Data Sheet: SBOS511

7.4 Device Functional Modes

7.4.1 Amplifier Operation

The INA250 current-sense amplifier can be configured to measure both unidirectional and bidirectional currents through the reference voltage level applied to the reference pin, REF. The reference voltage connected to REF sets the output level that corresponds with a zero input current condition. For unidirectional operation, tie the REF pin to ground so that when the current increases, the output signal also increases upwards from this reference voltage (or ground in this case). For bidirectional currents, an external voltage source can be used as the reference voltage connected to the REF pin to bias up the output. Set the reference voltage to enable sufficient range above and below this level based on the expected current range to be measured. Positive currents result in an output signal that increases from the zero-current output level set by the reference voltage whereas negative currents result in an output signal that decreases.

For both unidirectional and bidirectional applications, the amplifier transfer function is shown in 式 1:

$$V_{OUT} = (I_{LOAD} \times GAIN) + V_{REF} \tag{1}$$

where:

- I_{LOAD} is the current being measured passing through the internal shunt resistor,
- GAIN is the corresponding gain (mA/V) of the selected device, and
- V_{REF} is the voltage applied to the REF pin

As with any difference amplifier, the INA250 common-mode rejection ratio is affected by any impedance present at the REF input. This concern is not a problem when the REF pin is connected directly to a reference or power supply. When using resistive dividers from a power supply or a reference voltage, buffer the REF pin with an op amp.

7.4.2 Input Filtering

An obvious and straightforward location for filtering is at the device output; however, this location negates the advantage of the low output impedance of the output stage buffer. The input then represents the best location for implementing external filtering. 図 7-4 shows the typical implementation of the input filter for the device.

$$f_{-3dB} = \frac{1}{2\pi R_S C_F}$$

図 7-4. Input Filter

The addition of external series resistance at the input pins to the amplifier, however, creates an additional error in the measurement. Keep the value of these series resistors to 10 Ω or less, if possible, to reduce the affect to accuracy. The internal bias network illustrated in 図 7-4 present at the input pins creates a mismatch in input bias currents when a differential voltage is applied between the input pins, as shown in 図 7-5.
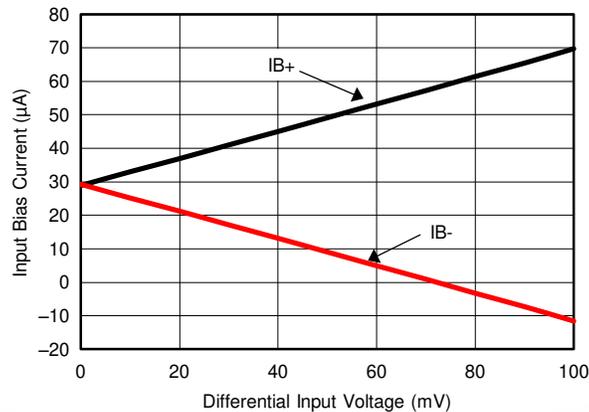

図 7-5. Input Bias Current vs Differential Input Voltage

7.4.2.1 Calculating Gain Error Resulting from External Filter Resistance

If additional external series filter resistors are added to the circuit, the mismatch in bias currents results in a mismatch of voltage drops across the filter resistors. This mismatch creates a differential error voltage that subtracts from the voltage developed across the Kelvin connection of the shunt resistor, thus reducing the voltage that reaches the amplifier input terminals. Without the additional series resistance, the mismatch in input bias currents has little effect on device operation as a result of the low input bias current of the amplifier and the typically low impedance of the traces between the shunt and amplifier input pins. The amount of error these external filter resistors add to the measurement can be calculated using 式 3, where the gain error factor is calculated using 式 2.

The amount of variance between the differential voltage present at the device input relative to the voltage developed at the shunt resistor is based both on the external series resistance value as well as the internal input resistors, R_{INT}; see 図 7-4. The reduction of the shunt voltage reaching the device input pins appears as a gain error when comparing the output voltage relative to the voltage across the shunt resistor. A factor can be calculated to determine the amount of gain error that is introduced by the addition of external series resistance. 式 2 calculates the expected deviation from the shunt voltage compared to the expected voltage at the device input pins.

$$\text{Gain Error Factor} = \frac{(1250 \times R_{INT})}{(1250 \times R_S) + (1250 \times R_{INT}) + (R_S \times R_{INT})} \tag{2}$$

where:

- R_{INT} is the internal input resistor and
- R_S is the external series resistance

$$\text{Gain Error (\%)} = 100 - (100 \times \text{Gain Error Factor}) \tag{3}$$

With the adjustment factor equation including the device internal input resistance, this factor varies with each gain version; see 表 7-1. Each individual device gain error factor is listed in 表 7-2.

The gain error that can be expected from the addition of the external series resistors can then be calculated based on 式 3.

表 7-1. Input Resistance

DEVICE	GAIN	R_{INT}
INA250A1	200 mV/A	50 kΩ
INA250A2	500 mV/A	20 kΩ
INA250A3	800 mV/A	12.5 kΩ
INA250A4	2 V/A	5 kΩ

表 7-2. Device Gain Error Factor

DEVICE	SIMPLIFIED GAIN ERROR FACTOR
INA250A1	$\dfrac{50,000}{(41 \bullet R_S) + 50,000}$
INA250A2	$\dfrac{20,000}{(17 \bullet R_S) + 20,000}$
INA250A3	$\dfrac{12,500}{(11 \bullet R_S) + 12,500}$
INA250A4	$\dfrac{1,000}{R_S + 1,000}$

For example, using an INA250A2 and the corresponding gain error equation from 表 7-2, a series resistance of 10 Ω results in a gain error factor of 0.991. The corresponding gain error is then calculated using 式 3, resulting in a gain error of approximately 0.84% because of the external 10-Ω series resistors.

7.4.3 Shutting Down the Device

Although the device does not have a shutdown pin, the low power consumption allows for the device to be powered from the output of a logic gate or transistor switch that can turn on and turn off the voltage connected to the device power-supply pin. However, in current-shunt monitoring applications, there is also a concern for how much current is drained from the shunt circuit in shutdown conditions. Evaluating this current drain involves considering the device simplified schematic in shutdown mode, as shown in 図 7-6.
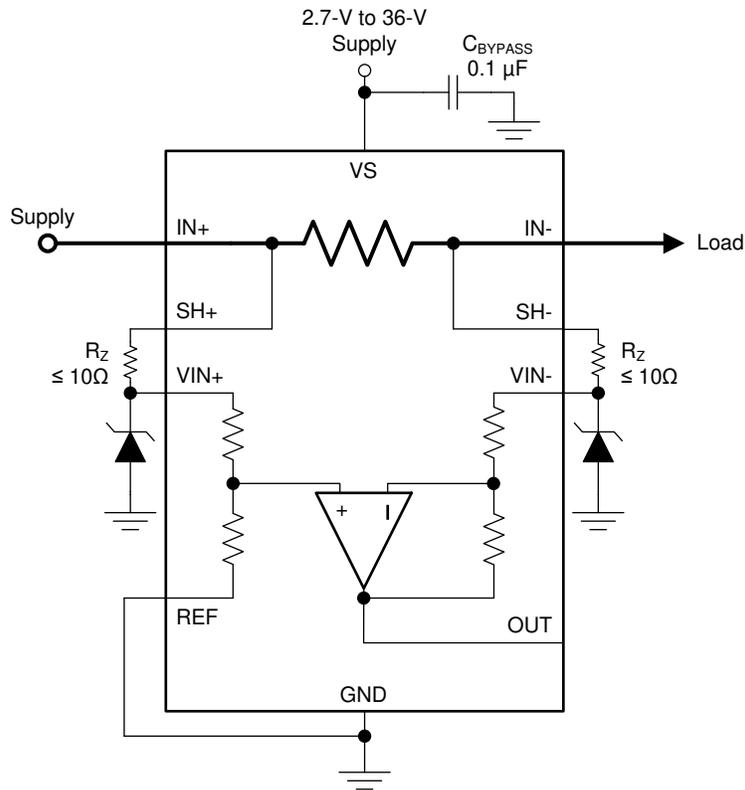
Product Folder Links: *INA250A1 INA250A2 INA250A3 INA250A4*

English Data Sheet: SBOS511
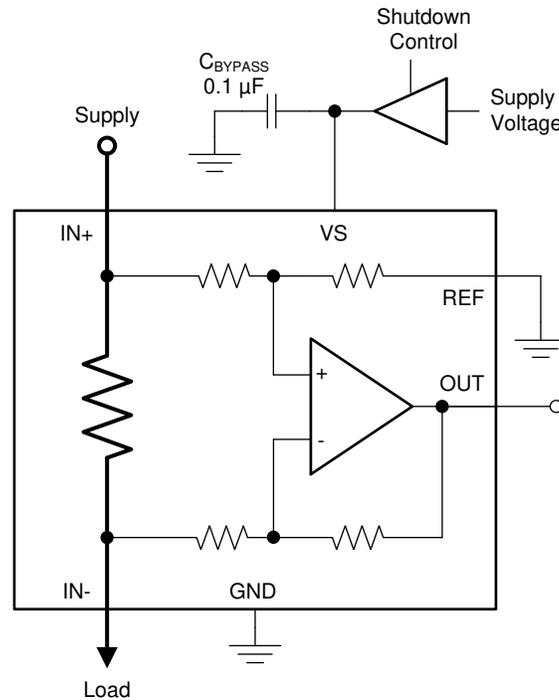
図 7-6. Shutting Down the Device

Note that there is typically an approximate 1-MΩ impedance (from the combination of the feedback and input resistors) from each device input to the REF pin. The amount of current flowing through these pins depends on the respective configuration. For example, if the REF pin is grounded, calculating the effect of the 1-MΩ impedance from the shunt to ground is straightforward. However, if the reference or op amp is powered when the device is shut down, the calculation is direct. Instead of assuming 1 MΩ to ground, assume 1 MΩ to the reference voltage. If the reference or op amp is also shut down, some knowledge of the reference or op amp output impedance under shutdown conditions is required. For instance, if the reference source functions similar to an open circuit when un-powered, little or no current flows through the 1-MΩ path.

7.4.4 Using the Device with Common-Mode Transients Above 36 V

With a small amount of additional circuitry, the device can be used in circuits subject to transients higher than 36 V (such as in automotive applications). Use only zener diodes or zener-type transient absorbers (sometimes referred to as *transzorbs*); any other type of transient absorber has an unacceptable time delay. Start by adding a pair of resistors, as shown in 図 7-7, as a working impedance for the zener. Keeping these resistors as small as possible is preferable, most often approximately 10 Ω. This value limits the affect on accuracy with the addition of these external components, as described in the *Input Filtering* section. Device interconnections between the shunt resistor and amplifier have a current handling limit of 1 A. Using a 10-Ω resistor limits the allowable transient range to 10 V above the zener clamp in order to not damage the device. Larger resistor values can be used in this protection circuit to accommodate a larger transient voltage range, resulting in a larger affect on gain error. Because this circuit limits only short-term transients, many applications are satisfied with a 10-Ω resistor along with conventional zener diodes of the lowest power rating available.

Product Folder Links: *INA250A1 INA250A2 INA250A3 INA250A4*

English Data Sheet: SBOS511

図 7-7. Device Transient Protection

8 Applications and Implementation

注

以下のアプリケーション情報は、TI の製品仕様に含まれるものではなく、TI ではその正確性または完全性を保証いたしません。個々の目的に対する製品の適合性については、お客様の責任で判断していただくことになります。お客様は自身の設計実装を検証しテストすることで、システムの機能を確認する必要があります。

8.1 Application Information

The INA250 measures the voltage developed across the internal current-sensing resistor when current passes through it. The ability to drive the reference pin to adjust the functionality of the output signal offers multiple configurations, as discussed in this section.
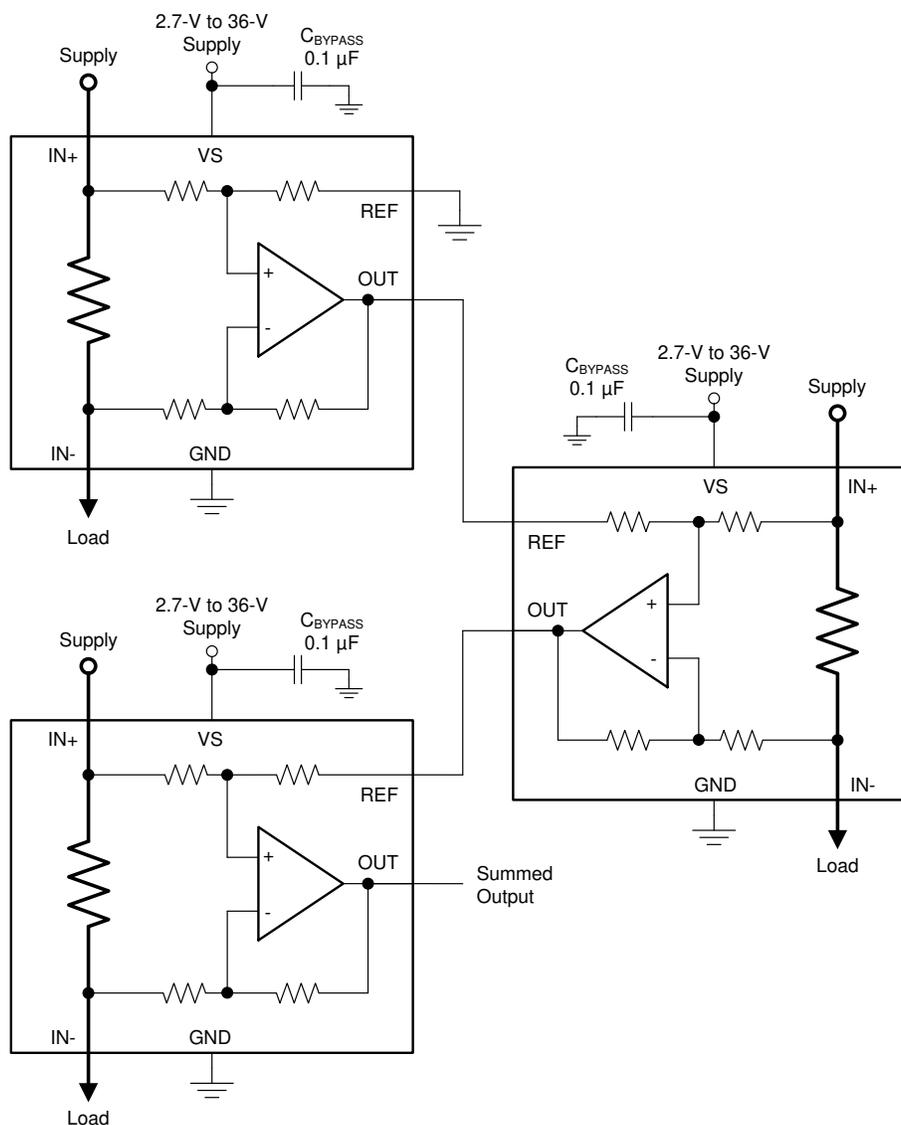
8.2 Typical Applications

8.2.1 Current Summing

図 8-1. Daisy-Chain Configuration

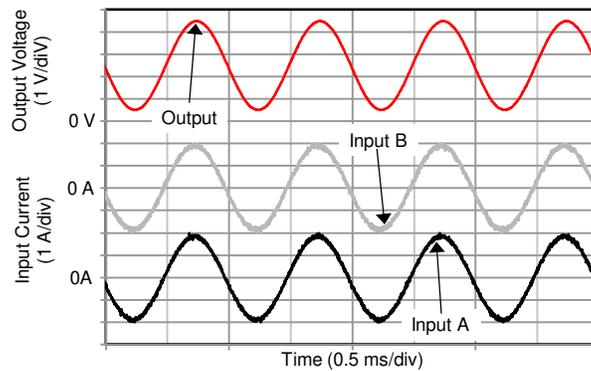Product Folder Links: *INA250A1 INA250A2 INA250A3 INA250A4*

English Data Sheet: SBOS511

8.2.1.1 Design Requirements

Three daisy-chained devices are illustrated in 図 8-1. The reference input of the first INA250 sets the quiescent level on the output of all the INA250 devices in the string.

8.2.1.2 Detailed Design Procedure

The outputs of multiple INA250 devices are easily summed by connecting the output signal of one INA250 to the reference input of a second INA250. Summing beyond two devices is possible by repeating this configuration, connecting the output signal of the next INA250 to the reference pin of a subsequent INA250 in the chain. The output signal of the final INA250 in this chain includes the current level information for all channels in the chain.
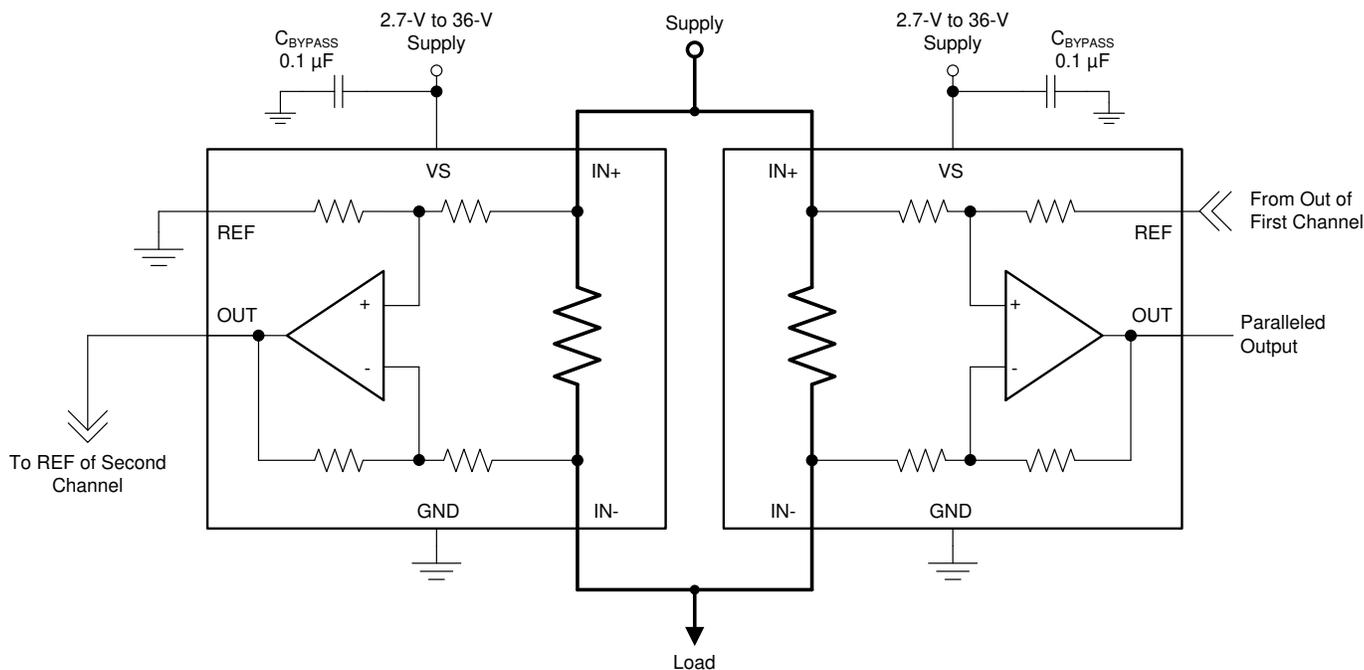
8.2.1.3 Application Curve

$VS = 5\ V,\ V_{REF} = 2.5\ V$

図 8-2. Daisy-Chain Configuration Output Response

資料に関するフィードバック(ご意見やお問い合わせ)を送信
Product Folder Links: *INA250A1 INA250A2 INA250A3 INA250A4*
English Data Sheet: SBOS511

8.2.2 Parallel Multiple INA250 Devices for Higher Current
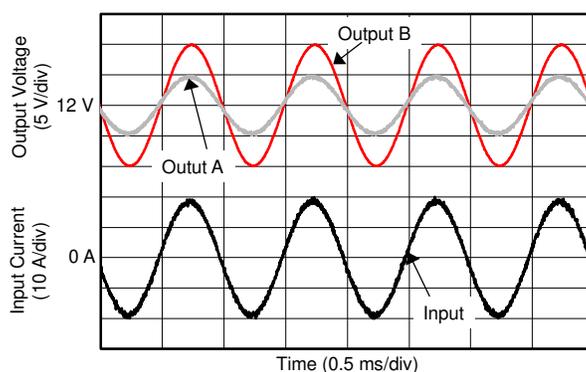
図 8-3. Parallel Summing Configuration

8.2.2.1 Design Requirements

The parallel connection for multiple INA250 devices can be used to reduce the equivalent overall sense resistance, enabling monitoring of higher current levels than a single device is able to accommodate alone. This configuration also uses a summing arrangement, as described in the *Current Summing* section. A parallel summing configuration is shown in 図 8-3.

8.2.2.2 Detailed Design Procedure

With a summing configuration the output of the first channel is fed into the reference input of the second, adding the distributed measurements back together into a single measured value.

8.2.2.3 Application Curve

VS = 24 V, V$_{REF}$ = 12 V

図 8-4. Parallel Configuration Output Response

Product Folder Links: *INA250A1 INA250A2 INA250A3 INA250A4*

English Data Sheet: *SBOS511*

8.2.3 Current Differencing
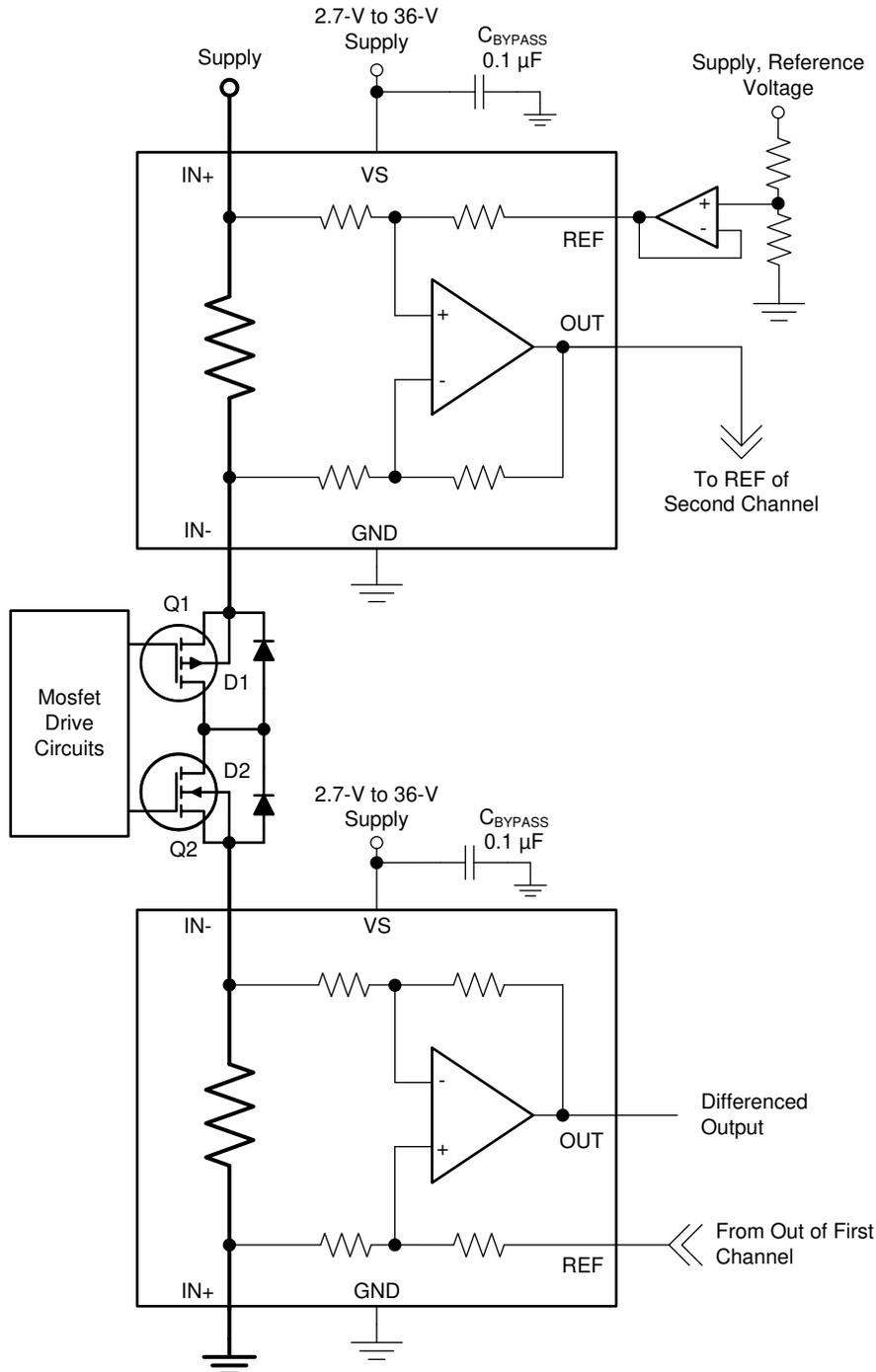
図 8-5. Current Differencing Configuration

8.2.3.1 Design Requirements

Occasionally, the need may arise to confirm that the current into a load is identical to the current coming out of a load, such as when performing diagnostic testing or fault detection. This procedure requires precision current differencing. This method is the same as current summing, except that the two amplifiers have the respective inputs connected opposite of each other. Under normal operating conditions, the final output is very close to the

reference value and proportional to any current difference. 図 8-5 is an example of two INA250 devices connected for current differencing.

8.2.3.2 Detailed Design Procedure

The load current can also be measured directly at the output of the first channel. Although technically this configuration is current differencing, this connection (see 図 8-5) is really intended to allow the upper (positive) sense channel to report any positive-going excursions in the overall output and the lower (negative) sense channel to report any negative-going excursions.

8.2.3.3 Application Curve
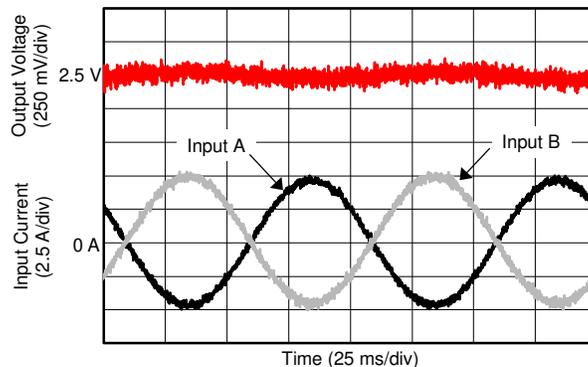
VS = 5 V, V$_{REF}$ = 2.5 V

図 8-6. Current Differencing Configuration Output Response

8.3 Power Supply Recommendations

The input circuitry of the device can accurately measure signals on common-mode voltages beyond the power-supply voltage, VS. For example, the voltage applied to the VS power-supply pin can be 5 V, whereas the load power-supply voltage being monitored (the common-mode voltage) can be as high as 36 V. Note also that the device can withstand the full 0-V to 36-V range at the input pins, regardless of whether the device has power applied or not. Power-supply bypass capacitors are required for stability and must be placed as closely as possible to the supply and ground pins of the device. A typical value for this supply bypass capacitor is 0.1 µF. Applications with noisy or high-impedance power supplies can require additional decoupling capacitors to reject power-supply noise.

8.4 Layout

8.4.1 Layout Guidelines

- The INA250 is specified for current handling of up to 10 A over the entire –40°C to 125°C temperature range using a 1-oz. copper pour for the input power plane as well as no external airflow passing over the device.
- The primary current-handling limitation for the INA250 is how much heat is dissipated inside the package. Efforts to improve heat transfer out of the package and into the surrounding environment improve the ability of the device to handle currents of up to 15 A over the entire –40°C to 125°C temperature range.
- Heat transfer improvements primarily involve larger copper power traces and planes with increased copper thickness (2 oz.) as well as providing airflow to pass over the device. The INA250EVM features a 2-oz. copper pour for the planes and is capable of supporting 15 A at temperatures up to 125°C.
- Place the power-supply bypass capacitor as close as possible to the supply and ground pins. The recommended value of this bypass capacitor is 0.1 µF. Additional decoupling capacitance can be added to compensate for noisy or high-impedance power supplies.

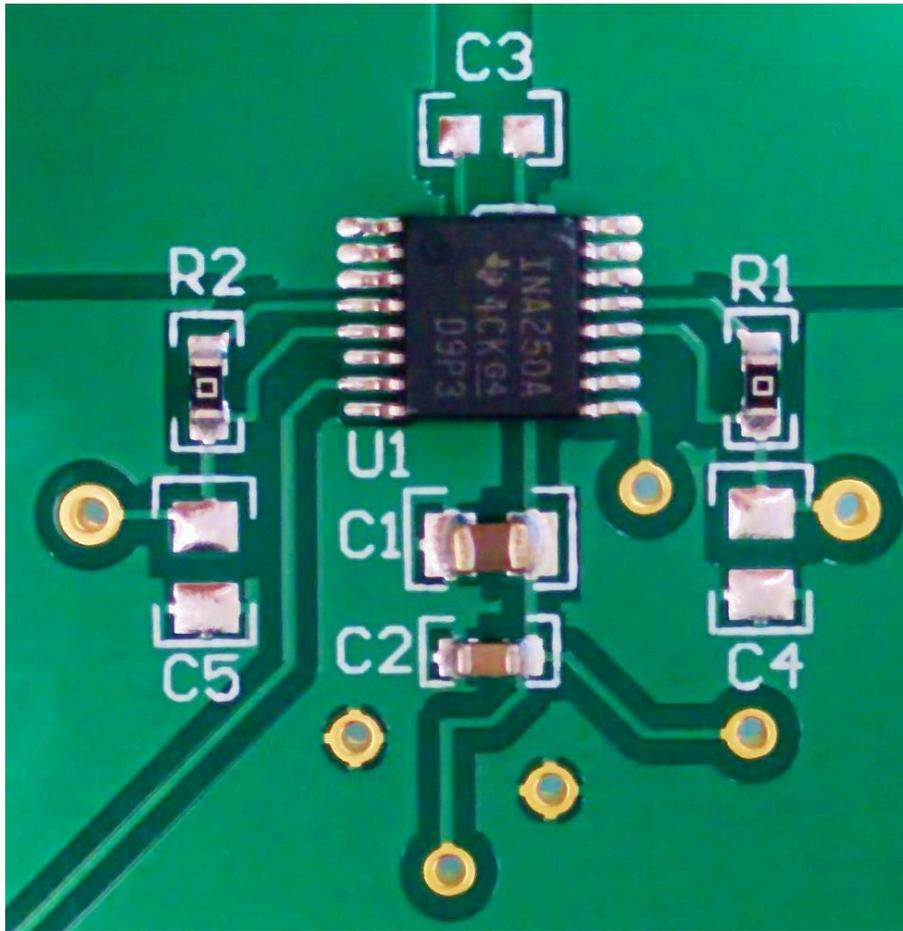Product Folder Links: *INA250A1 INA250A2 INA250A3 INA250A4*

English Data Sheet: SBOS511

8.4.2 Layout Examples

図 8-7. Recommended Layout
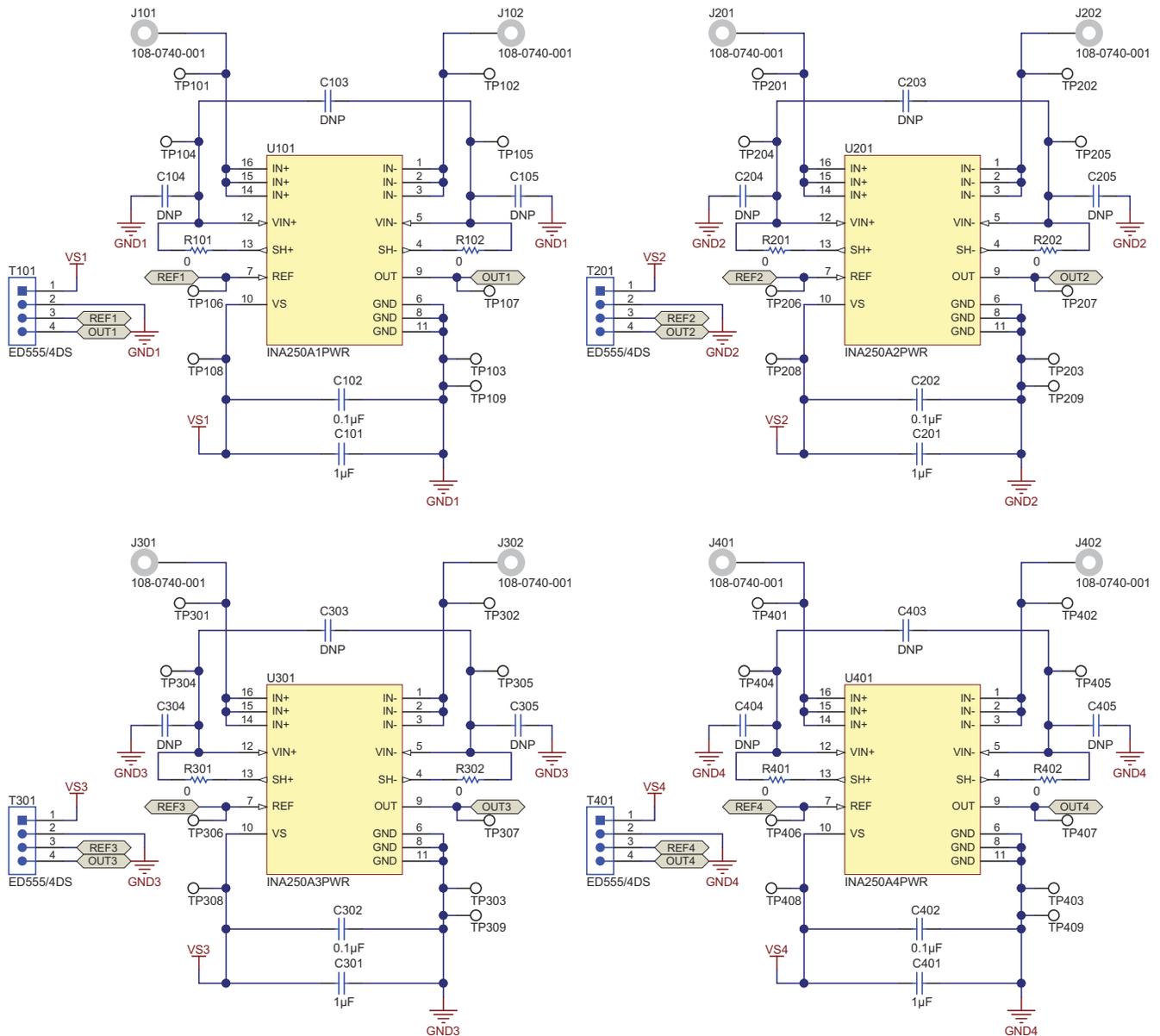
図 8-8. Recommended Layout Schematic

Product Folder Links: *INA250A1 INA250A2 INA250A3 INA250A4*

English Data Sheet: SBOS511

9 Device and Documentation Support

9.1 Documentation Support

9.1.1 Related Documentation

- INA250EVM User Guide, SBOU153

9.2 ドキュメントの更新通知を受け取る方法

ドキュメントの更新についての通知を受け取るには、ti.com のデバイス製品フォルダを開いてください。「更新の通知を受け取る」をクリックして登録すると、変更されたすべての製品情報に関するダイジェストを毎週受け取れます。変更の詳細については、修正されたドキュメントに含まれている改訂履歴をご覧ください。

9.3 サポート・リソース

TI E2E™ サポート・フォーラムは、エンジニアが検証済みの回答と設計に関するヒントをエキスパートから迅速かつ直接得ることができる場所です。既存の回答を検索したり、独自の質問をしたりすることで、設計で必要な支援を迅速に得ることができます。

リンクされているコンテンツは、該当する貢献者により、現状のまま提供されるものです。これらは TI の仕様を構成するものではなく、必ずしも TI の見解を反映したものではありません。TI の使用条件を参照してください。

9.4 Trademarks

TI E2E™ is a trademark of Texas Instruments.
すべての商標は、それぞれの所有者に帰属します。

9.5 静電気放電に関する注意事項

この IC は、ESD によって破損する可能性があります。テキサス・インスツルメンツは、IC を取り扱う際には常に適切な注意を払うことを推奨します。正しい取り扱いおよび設置手順に従わない場合、デバイスを破損するおそれがあります。

ESD による破損は、わずかな性能低下からデバイスの完全な故障まで多岐にわたります。精密な IC の場合、パラメータがわずかに変化するだけで公表されている仕様から外れる可能性があるため、破損が発生しやすくなっています。

9.6 用語集

テキサス・インスツルメンツ用語集　　この用語集には、用語や略語の一覧および定義が記載されています。

10 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable part number (1)	Status (1)	Material type (2)	Package | Pins	Package qty | Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
INA250A1PW	Obsolete	Production	TSSOP (PW) | 16	-	-	Call TI	Call TI	-40 to 125	I250A1
INA250A1PWR	Active	Production	TSSOP (PW) | 16	2000 | LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	I250A1
INA250A1PWR.A	Active	Production	TSSOP (PW) | 16	2000 | LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	I250A1
INA250A1PWRG4	Active	Production	TSSOP (PW) | 16	2000 | LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	I250A1
INA250A1PWRG4.A	Active	Production	TSSOP (PW) | 16	2000 | LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	I250A1
INA250A2PW	Obsolete	Production	TSSOP (PW) | 16	-	-	Call TI	Call TI	-40 to 125	I250A2
INA250A2PWR	Active	Production	TSSOP (PW) | 16	2000 | LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	I250A2
INA250A2PWR.A	Active	Production	TSSOP (PW) | 16	2000 | LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	I250A2
INA250A2PWRG4	Active	Production	TSSOP (PW) | 16	2000 | LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	I250A2
INA250A2PWRG4.A	Active	Production	TSSOP (PW) | 16	2000 | LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	I250A2
INA250A3PW	Obsolete	Production	TSSOP (PW) | 16	-	-	Call TI	Call TI	-40 to 125	I250A3
INA250A3PWR	Active	Production	TSSOP (PW) | 16	2000 | LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	I250A3
INA250A3PWR.A	Active	Production	TSSOP (PW) | 16	2000 | LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	I250A3
INA250A3PWRG4	Active	Production	TSSOP (PW) | 16	2000 | LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	I250A3
INA250A3PWRG4.A	Active	Production	TSSOP (PW) | 16	2000 | LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	I250A3
INA250A4PW	Obsolete	Production	TSSOP (PW) | 16	-	-	Call TI	Call TI	-40 to 125	I250A4
INA250A4PWR	Active	Production	TSSOP (PW) | 16	2000 | LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	I250A4
INA250A4PWR.A	Active	Production	TSSOP (PW) | 16	2000 | LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	I250A4
INA250A4PWRG4	Active	Production	TSSOP (PW) | 16	2000 | LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	I250A4
INA250A4PWRG4.A	Active	Production	TSSOP (PW) | 16	2000 | LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	I250A4

(1) **Status:** For more details on status, see our product life cycle.

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.
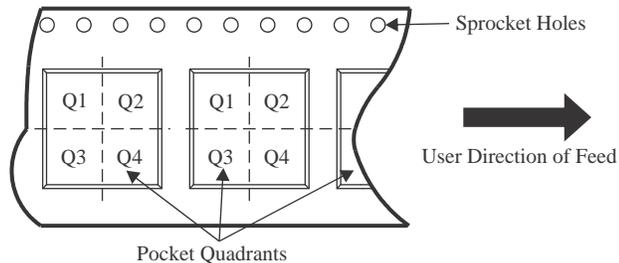
OTHER QUALIFIED VERSIONS OF INA250 :

● Automotive : INA250-Q1

NOTE: Qualified Version Definitions:

　　　● Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

PACKAGE MATERIALS INFORMATION

TAPE AND REEL INFORMATION

REEL DIMENSIONS

TAPE DIMENSIONS

A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

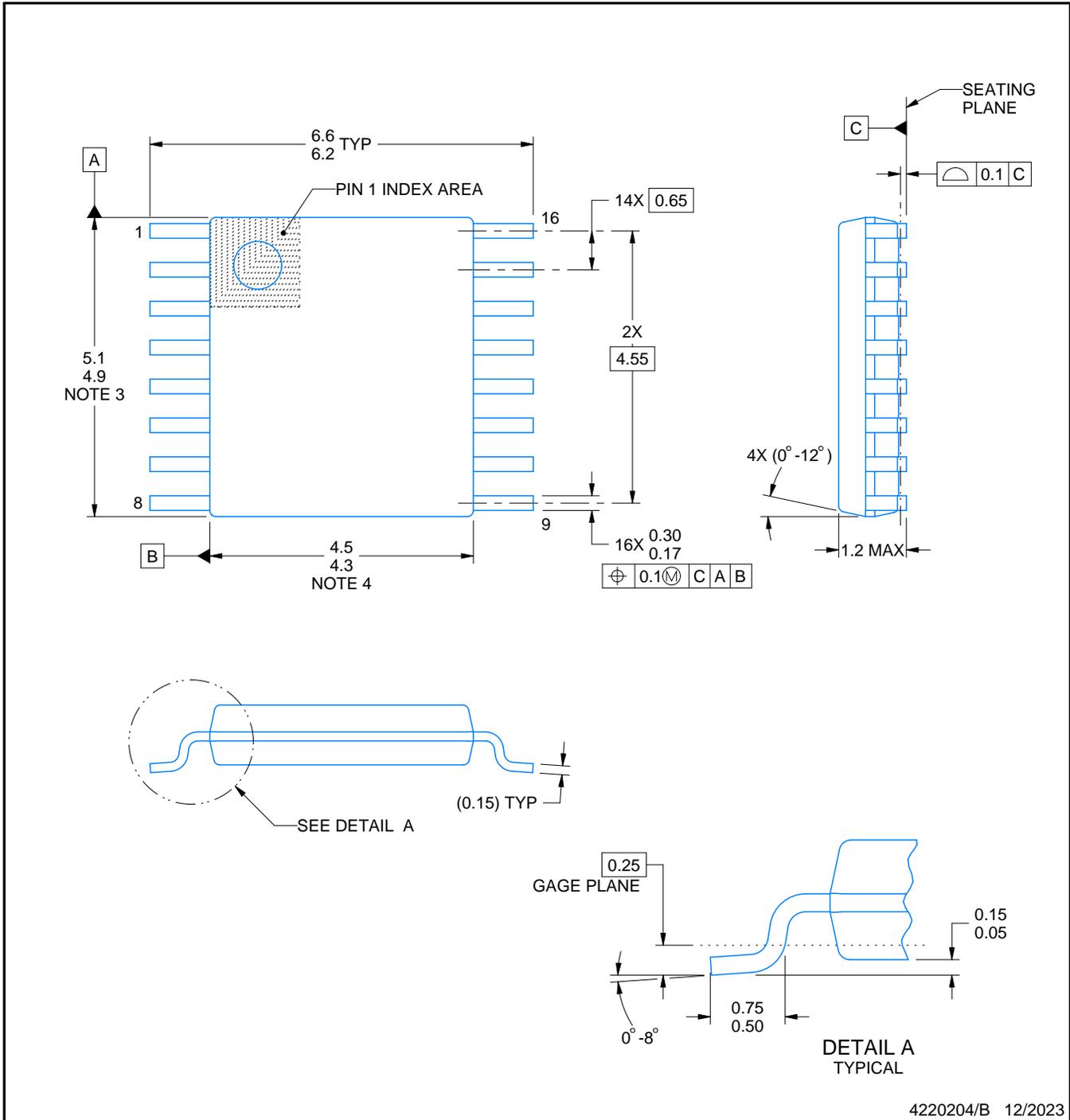**QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE**

*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
INA250A1PWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
INA250A1PWRG4	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
INA250A2PWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
INA250A2PWRG4	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
INA250A3PWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
INA250A3PWRG4	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
INA250A4PWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
INA250A4PWRG4	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1

TAPE AND REEL BOX DIMENSIONS

*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
INA250A1PWR	TSSOP	PW	16	2000	353.0	353.0	32.0
INA250A1PWRG4	TSSOP	PW	16	2000	353.0	353.0	32.0
INA250A2PWR	TSSOP	PW	16	2000	353.0	353.0	32.0
INA250A2PWRG4	TSSOP	PW	16	2000	353.0	353.0	32.0
INA250A3PWR	TSSOP	PW	16	2000	353.0	353.0	32.0
INA250A3PWRG4	TSSOP	PW	16	2000	353.0	353.0	32.0
INA250A4PWR	TSSOP	PW	16	2000	353.0	353.0	32.0
INA250A4PWRG4	TSSOP	PW	16	2000	353.0	353.0	32.0

SEATING PLANE

C

0.1 C

A

6.6
6.2 TYP

PIN 1 INDEX AREA

14X 0.65

16

5.1
4.9
NOTE 3

1

2X

4.55

8

9

B

4.5
4.3
NOTE 4

16X 0.30
0.17

⊕ 0.1 Ⓜ C A B

4X (0°-12°)

1.2 MAX

SEE DETAIL A

(0.15) TYP

0.25
GAGE PLANE

0.15
0.05

0°-8°

0.75
0.50

DETAIL A
TYPICAL

4220204/B   12/2023

NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-153.

16X (1.5)

SYMM

(R0.05) TYP

1

16X (0.45)

16

SYMM

14X (0.65)

8

9

(5.8)
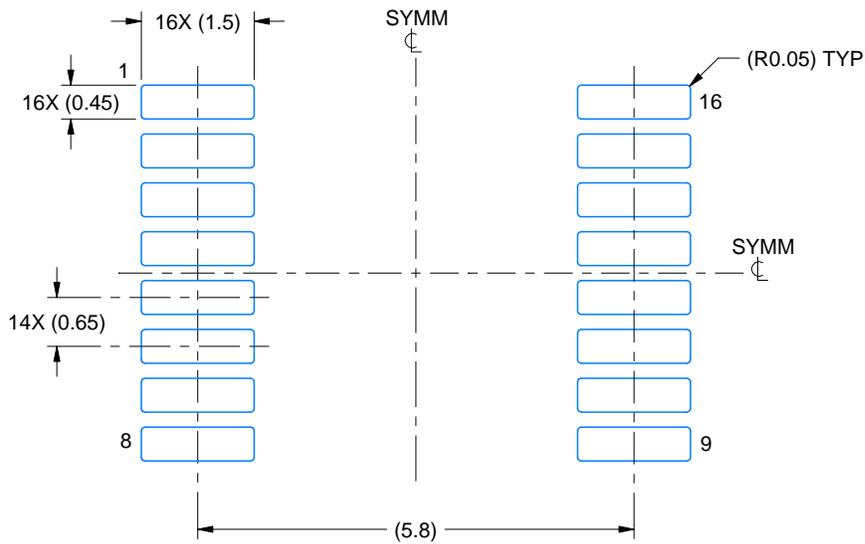
LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 10X

SOLDER MASK
OPENING

METAL

EXPOSED METAL

0.05 MAX
ALL AROUND

NON-SOLDER MASK
DEFINED
(PREFERRED)

METAL UNDER
SOLDER MASK

SOLDER MASK
OPENING

EXPOSED METAL

0.05 MIN
ALL AROUND

SOLDER MASK
DEFINED
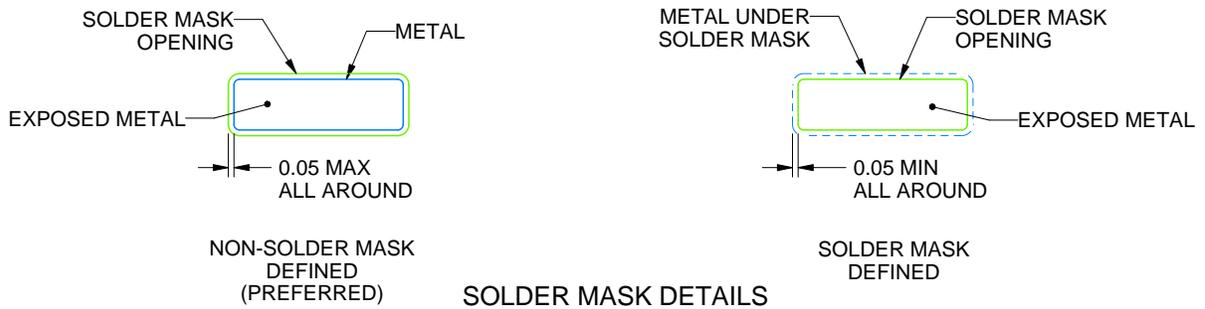
SOLDER MASK DETAILS

4220204/B   12/2023

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

16X (1.5)

SYMM

1

16X (0.45)

(R0.05) TYP

16

SYMM

14X (0.65)

8

9

(5.8)
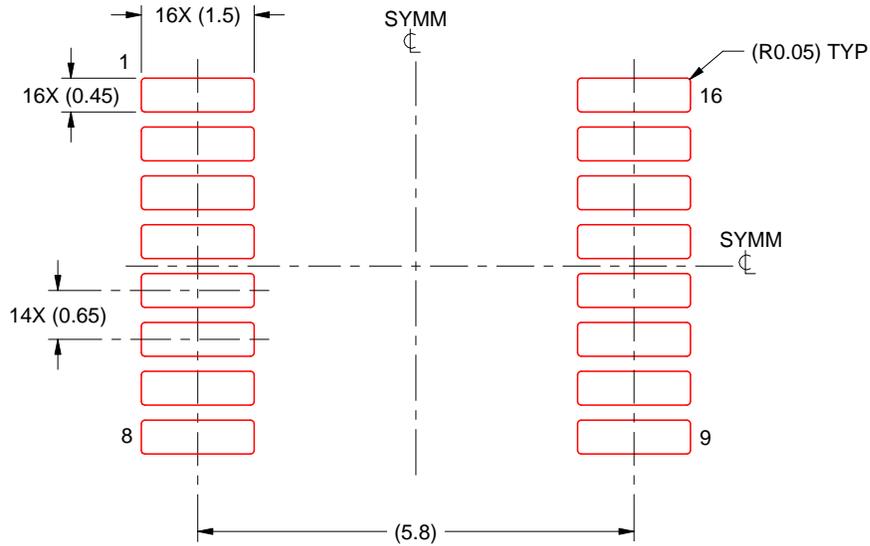
SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE: 10X

4220204/B　12/2023

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate
design recommendations.
9. Board assembly site may have different recommendations for stencil design.